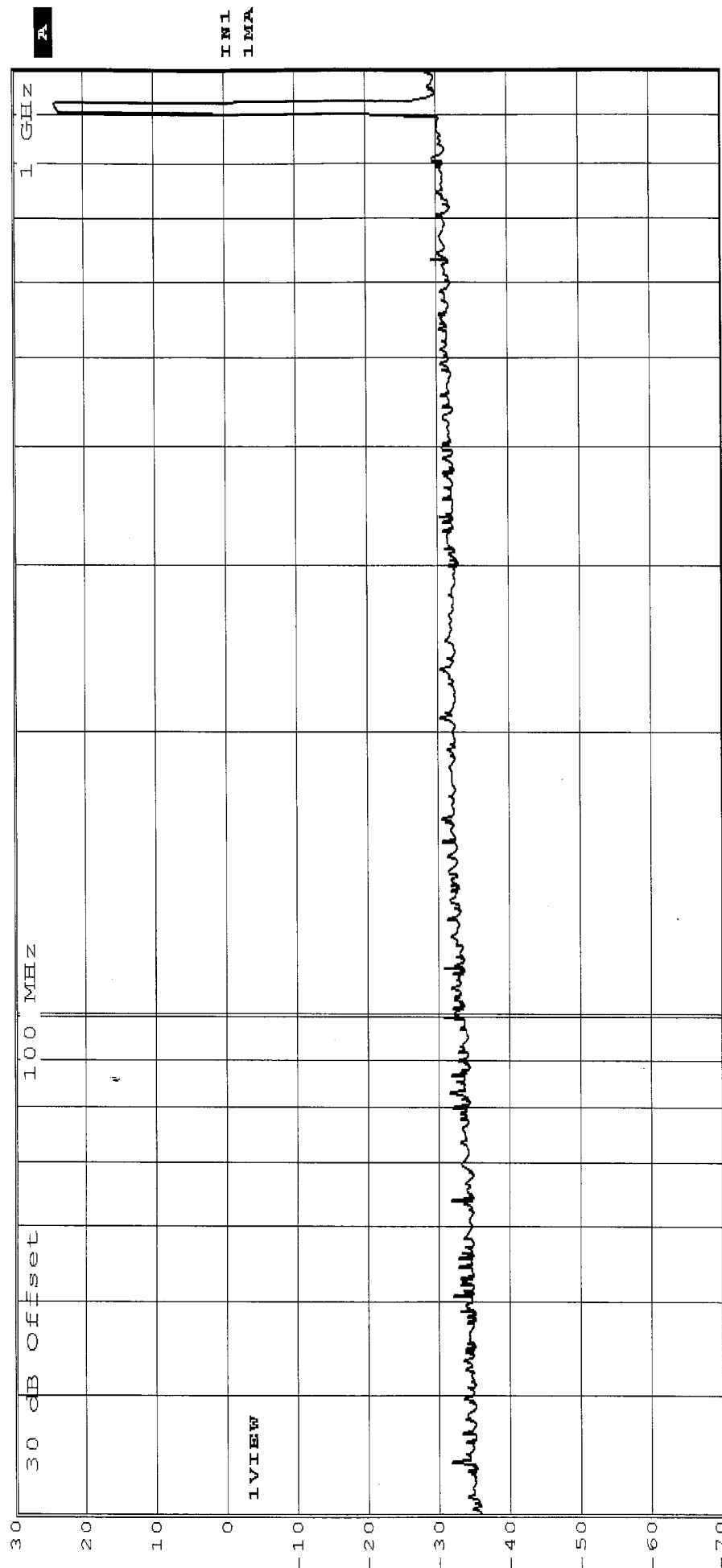


RETLIF TESTING LABORATORIES

EMISSIONS DATA SHEET

Test Method:		Spurious RF Conducted Emissions 30 MHz to 9.5 GHz	
Customer:	Markem Corporation	Test Sample:	Thermal Printer with RFID
Model No:	CIMJET RFID	Serial No:	04 C3D 3554
Test Specification:	FCC Part 15, Subpart C	Paragraph:	15.247(c)
Operating Mode:	Transmitting a modulated signal		
Notes:	Frequency Tested: Frequency Hopping 902.41-926.53 MHz		
Ref Lvl		RF Att	30 dB
30 dBm		VBW	300 kHz
		SWT	245 ms
		Unit	dBm
		Spurious Limit:	3.29 dBm



RETLIF TESTING LABORATORIES

EMISSIONS DATA SHEET

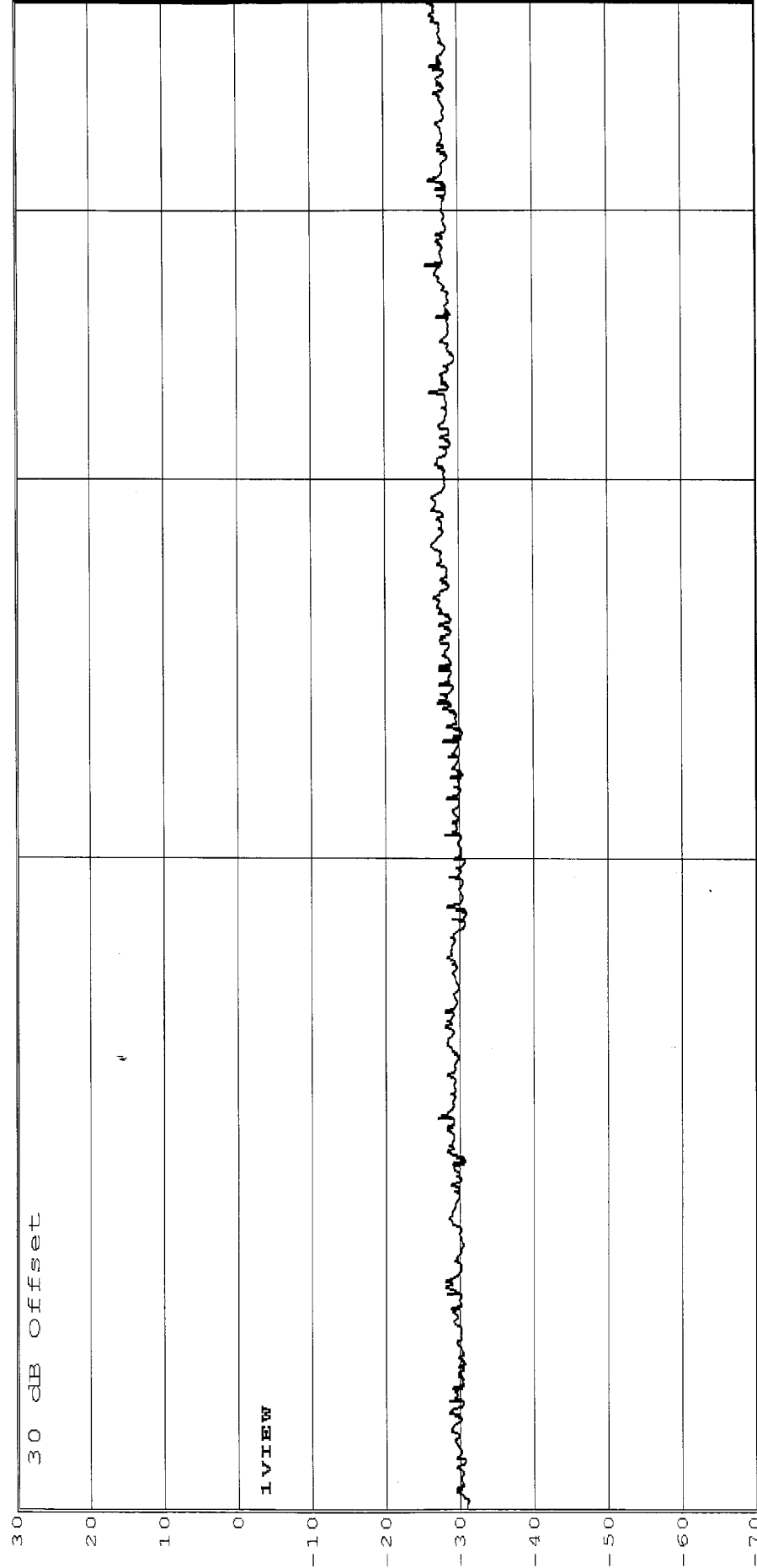
Test Method: Spurious RF Conducted Emissions 30 MHz to 9.5 GHz	
Customer: Markem Corporation	Job No: R-4396N
Model No: CIMJET RFID	Technician: T. Firkowski
Test Specification: FCC Part 15, Subpart C	Date: 2/23/2005
Operating Mode: Transmitting a modulated signal	
Notes: Frequency Tested: Frequency Hopping 902.41-926.53 MHz Spurious Limit: 3.29 dBm	



Ref Lvl
30 dBm

RBW 100 kHz
VBW 300 kHz
SWT 1 s
Unit dBm

30 dB Offset



VIEW

IM1
IM2

Start 1 GHz

Stop 5 GHz

Date: 23.FEB.2005 15:22:40

Data Sheet 2 of 3

R-4396N

RETLIF TESTING LABORATORIES

EMISSIONS DATA SHEET

Test Method:	Spurious RF Conducted Emissions 30 MHz to 9.5 GHz		
Customer:	Markem Corporation	Test Sample:	Thermal Printer with RFID
Model No:	CIMJET RFID	Serial No:	04 C3D 3554
Test Specification:	FCC Part 15, Subpart C		
Operating Mode:	Transmitting a modulated signal		
Notes:	Frequency Tested: Frequency Hopping 902.41-926.53 MHz		
	Spurious Limit: 3.29 dBm		

Job No:	R-4396N
Technician:	T. Firkowski
Date:	2/23/2005

Ref Lvl	30 dBm	RBW	100 kHz	RF Att	30 dB
		VBW	300 kHz		
		SWT	1.15 s	Unit	dBm

